Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/734,134	JANG, JAE-BUM
Examiner	Art Unit

2627

TAN X. DINH

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (see search history printout)	6/5/2007	T.D		
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